

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination WONG ET AL.
	Examiner Son P Huynh	Art Unit 2611

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,029,045 ✓	02-2000	Picco et al.	725/34
	B	US-5,798,785 ✓	08-1998	Hendricks et al.	725/46
	C	US-6,266,814 B1 ✓	07-2001	Lemmons et al.	725/44
	D	US-6,374,406 B2 ✓	04-2002	Hirata, Shinichi	725/132
	E	US-6,498,895 ✓	12-2002	Young et al.	386/83
	F	US-6,637,029 B1 ✓	10-2003	Maissel et al.	725/46
	G	US-2003/0149980 A1 ✓	08-2003	Hassell et al.	725/39
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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